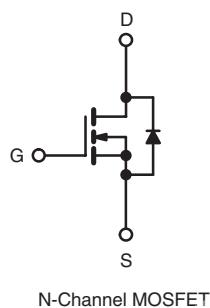
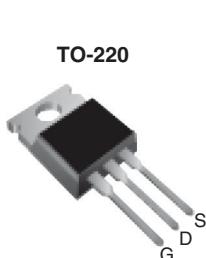


Power MOSFET

PRODUCT SUMMARY	
V_{DS} (V)	60
$R_{DS(on)}$ (Ω)	$V_{GS} = 5.0$ V 0.050
Q_g (Max.) (nC)	35
Q_{gs} (nC)	7.1
Q_{gd} (nC)	25
Configuration	Single



FEATURES

- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- $R_{DS(on)}$ Specified at $V_{GS} = 4$ V and 5 V
- 175 °C Operating Temperature
- Fast Switching
- Ease of Parallelizing
- Simple Drive Requirements
- Lead (Pb)-free Available



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220
Lead (Pb)-free	IRLZ34PbF SiHLZ34-E3
SnPb	IRLZ34 SiHLZ34

ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V_{DS}	60	V
Gate-Source Voltage		V_{GS}	± 10	
Continuous Drain Current	V_{GS} at 5 V	I_D	30	A
			21	
Pulsed Drain Current ^a		I_{DM}	110	
Linear Derating Factor			0.59	W/°C
Single Pulse Avalanche Energy ^b		E_{AS}	220	mJ
Maximum Power Dissipation	$T_C = 25$ °C	P_D	88	W
Peak Diode Recovery dV/dt ^c		dV/dt	4.5	V/ns
Operating Junction and Storage Temperature Range		T_J, T_{stg}	- 55 to + 175	°C
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d	
Mounting Torque	6-32 or M3 screw		10	lbf · in
			1.1	N · m

Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = 25$ V, starting $T_J = 25$ °C, $L = 285$ μ H, $R_G = 25$ Ω , $I_{AS} = 30$ A (see fig. 12).
- $I_{SD} \leq 30$ A, $dI/dt \leq 200$ A/ μ s, $V_{DD} \leq V_{DS}$, $T_J \leq 175$ °C.
- 1.6 mm from case.

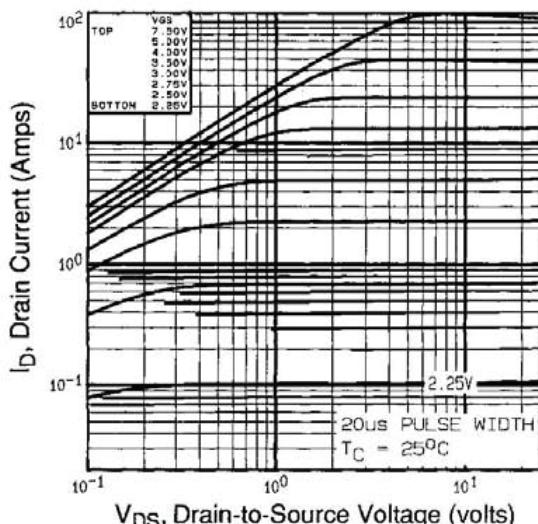
* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	°C/W
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.7	

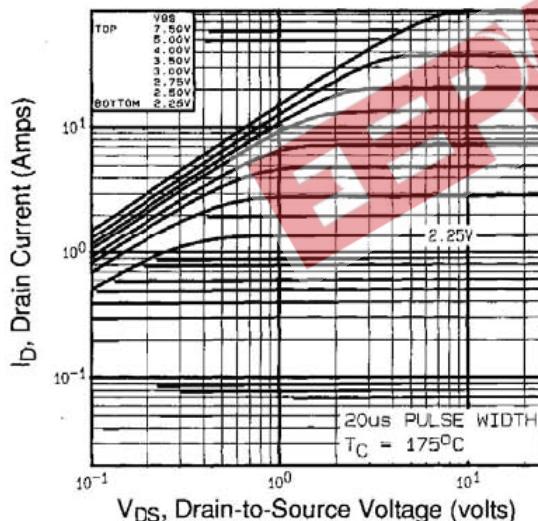
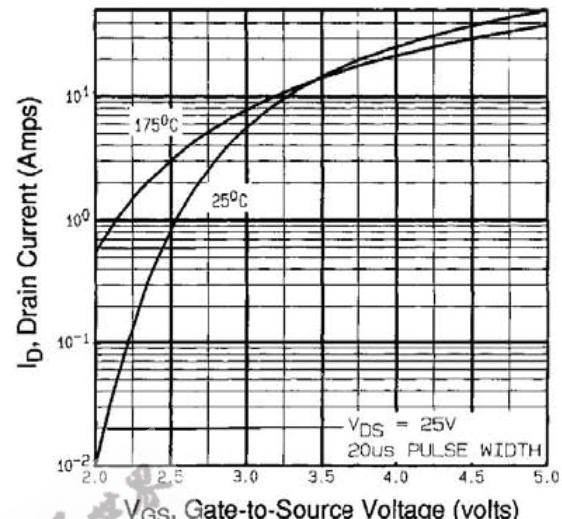
SPECIFICATIONS T _J = 25 °C, unless otherwise noted						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	60	-	-	V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	Reference to 25 °C, I _D = 1 mA	-	0.070	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1.0	-	2.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 10 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V	-	-	25	μA
		V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C	-	-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 5.0 V	I _D = 18 A ^b	-	0.050	Ω
		V _{GS} = 4.0 V	I _D = 15 A ^b	-	0.070	
Forward Transconductance	g _f	V _{DS} = 25 V, I _D = 18 A ^b	12	-	-	S
Dynamic						
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5	-	1600	-	pF
Output Capacitance	C _{oss}		-	660	-	
Reverse Transfer Capacitance	C _{rss}		-	170	-	
Total Gate Charge	Q _g	V _{GS} = 5.0 V I _D = 30 A, V _{DS} = 48 V see fig. 6 and 13 ^b	-	-	35	nC
Gate-Source Charge	Q _{gs}		-	-	7.1	
Gate-Drain Charge	Q _{gd}		-	-	25	
Turn-On Delay Time	t _{d(on)}		-	14	-	ns
Rise Time	t _r	V _{DD} = 30 V, I _D = 30 A R _G = 6.0 Ω, R _D = 1.0 Ω, see fig. 10 ^b	-	170	-	
Turn-Off Delay Time	t _{d(off)}		-	30	-	
Fall Time	t _f		-	56	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact	-	4.5	-	nH
Internal Source Inductance	L _S		-	7.5	-	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode	-	-	30	A
Pulsed Diode Forward Current ^a	I _{SM}		-	-	110	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 30 A, V _{GS} = 0 V ^b	-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 30 A, dI/dt = 100 A/μs ^b	-	120	180	ns
Body Diode Reverse Recovery Charge	Q _{rr}		-	0.70	1.3	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				

Notes

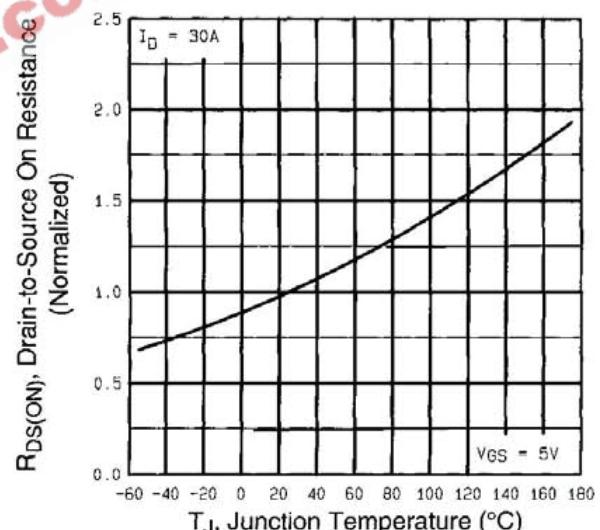
- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted


V_{DS} , Drain-to-Source Voltage (volts)
Fig. 1 - Typical Output Characteristics, $T_c = 25^\circ\text{C}$



V_{DS} , Drain-to-Source Voltage (volts)



IRLZ34, SiHLZ34

Vishay Siliconix

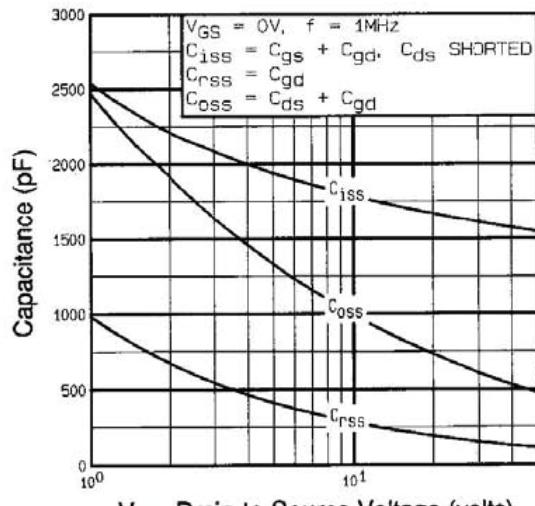


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

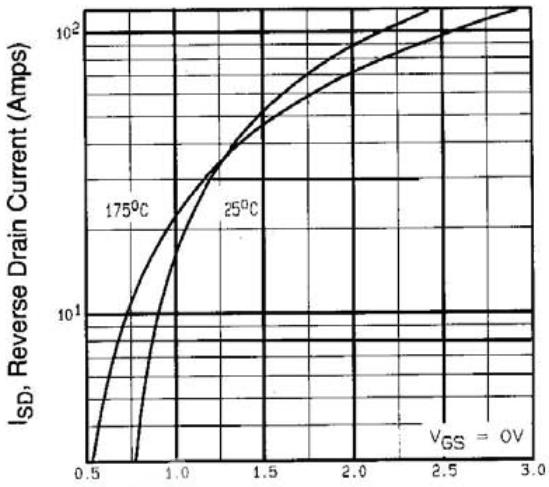


Fig. 7 - Typical Source-Drain Diode Forward Voltage

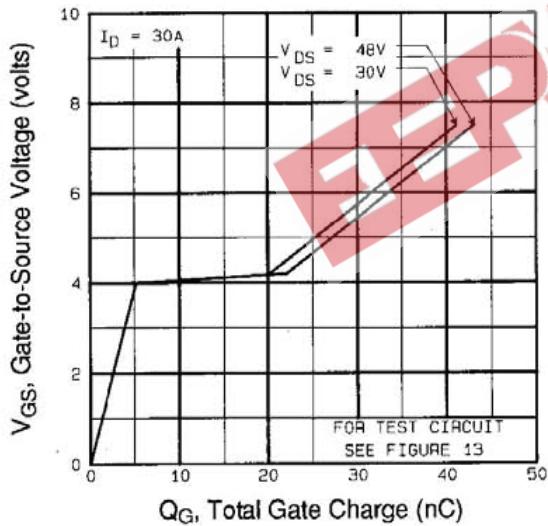


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage

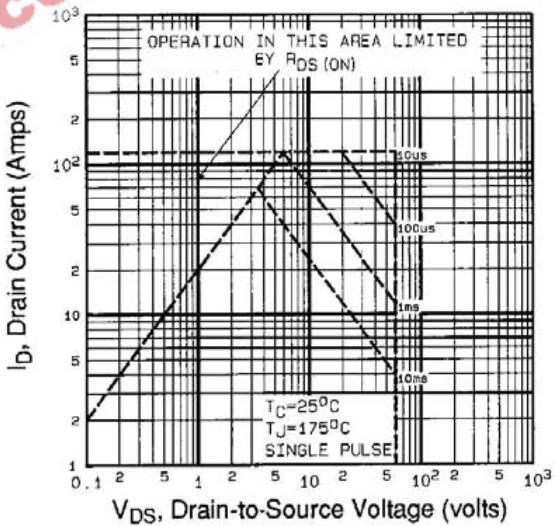


Fig. 8 - Maximum Safe Operating Area

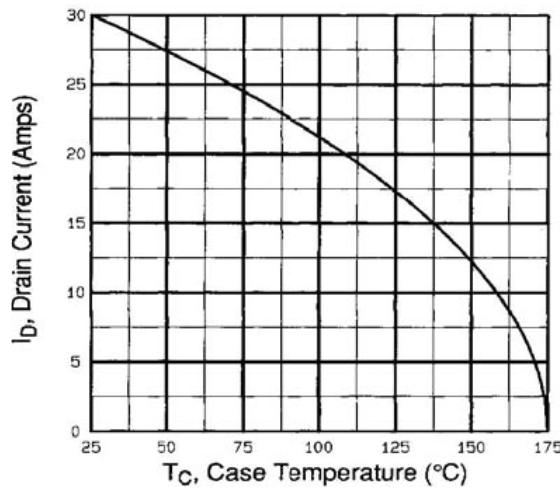


Fig. 9 - Maximum Drain Current vs. Case Temperature

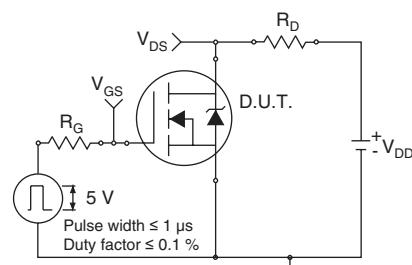


Fig. 10a - Switching Time Test Circuit

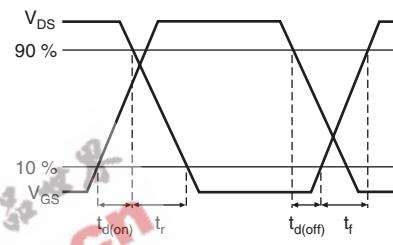


Fig. 10b - Switching Time Waveforms

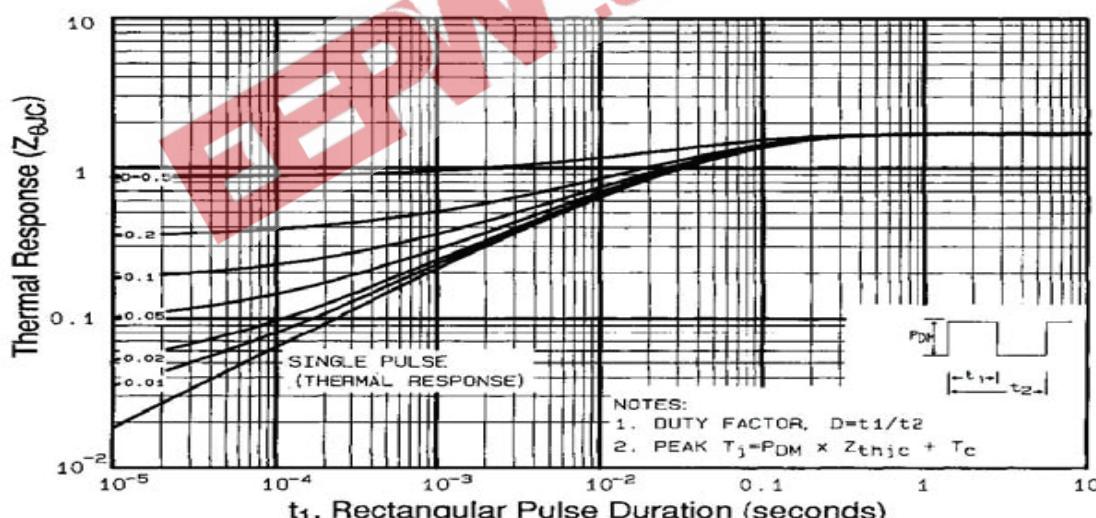


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

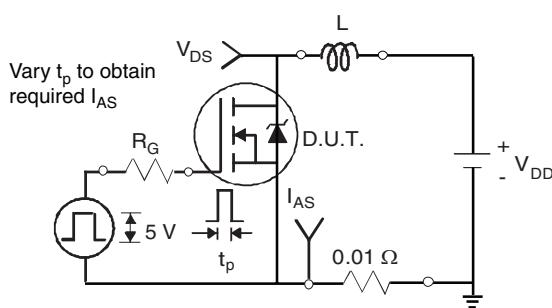


Fig. 12a - Unclamped Inductive Test Circuit

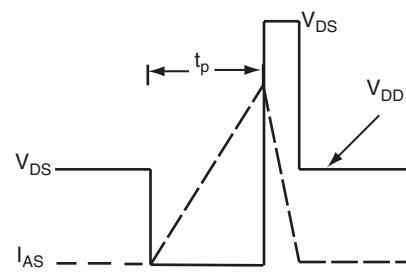


Fig. 12b - Unclamped Inductive Waveforms

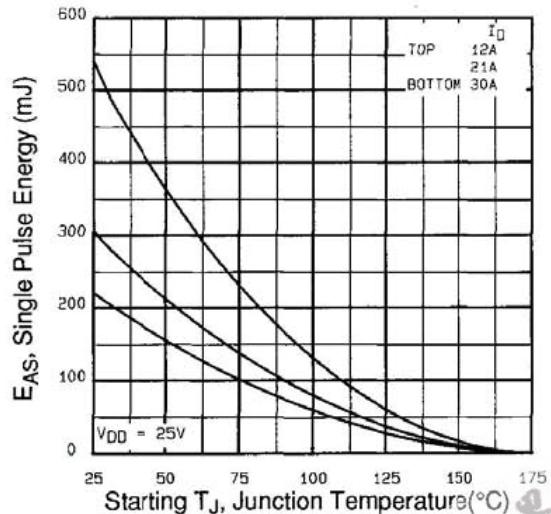


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

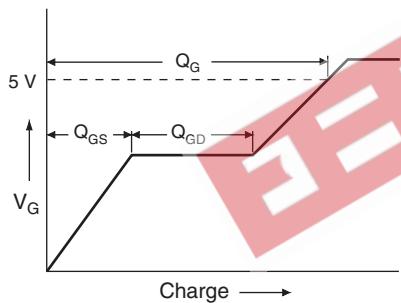


Fig. 13a - Basic Gate Charge Waveform

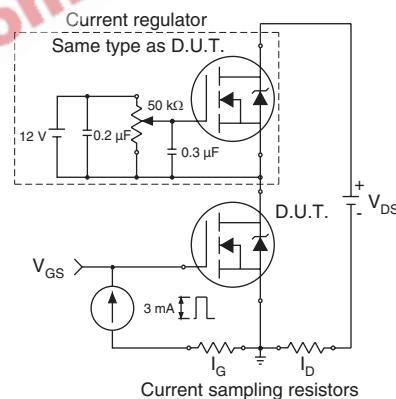
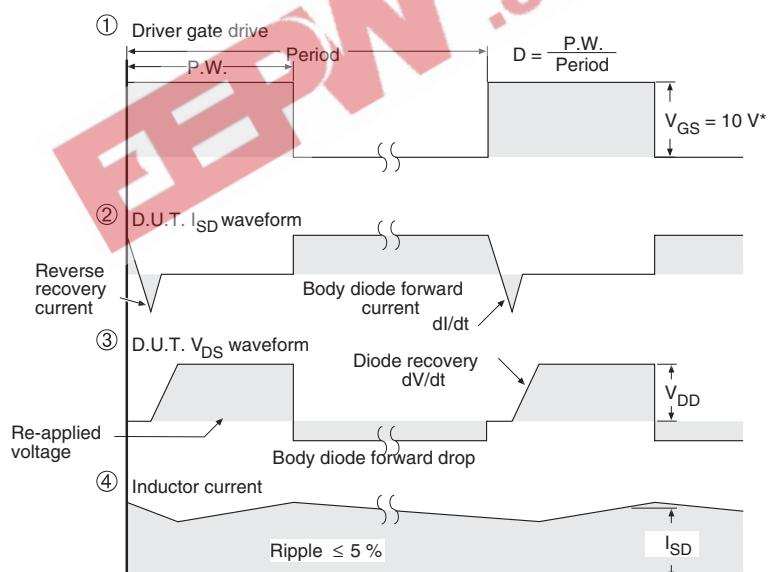
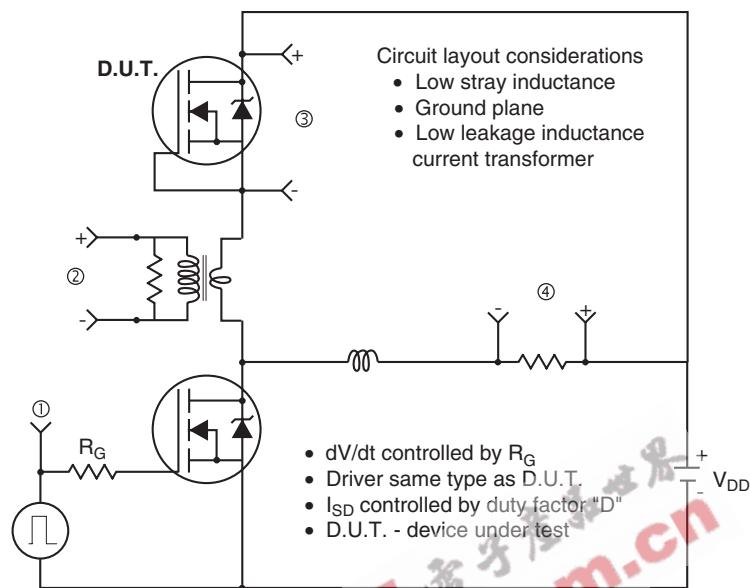


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



* $V_{GS} = 5 \text{ V}$ for logic level devices

Fig. 14 - For N-Channel

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